## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | LAIL ET AL. | Examiner | Art Unit | Hae M Hyeon | 2839 | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,621,842	04-1997	Keller, David	385/114
	В	US-6,278,826	08-2001	Sheu, Jim J.	385/109
	С	US-6,389,204	05-2002	Hurley, William C.	385/102
	D	US-			
	E	US-			
	F	US-			
	G	US-			,
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N		,			
	0					
	Р			·		
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.